

## NCE N-Channel Enhancement Mode Power MOSFET

### Description

The NCE0130 uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications.

### General Features

- $V_{DS} = 100V, I_D = 30A$   
 $R_{DS(ON)} < 28m\Omega @ V_{GS}=10V$  (Typ:24 m $\Omega$ )
- Special process technology for high ESD capability
- High density cell design for ultra low  $R_{dson}$
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high  $E_{AS}$
- Excellent package for good heat dissipation

### Application

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply

**100% UIS TESTED!**

**100%  $\Delta V_{ds}$  TESTED!**



Schematic diagram



Marking and pin assignment



TO-220-3L top view

### Package Marking and Ordering Information

| Device Marking | Device  | Device Package | Reel Size | Tape width | Quantity |
|----------------|---------|----------------|-----------|------------|----------|
| NCE0130        | NCE0130 | TO-220-3L      | -         | -          | -        |

### Absolute Maximum Ratings ( $T_C=25^\circ C$ unless otherwise noted)

| Symbol             | Parameter   | Limit      | Unit          |
|--------------------|---|------------|---------------|
| $V_{DS}$           | Drain-Source Voltage                              | 100        | V             |
| $V_{GS}$           | Gate-Source Voltage                               | $\pm 20$   | V             |
| $I_D$              | Drain Current-Continuous                          | 30         | A             |
| $I_D(100^\circ C)$ | Drain Current-Continuous( $T_C=100^\circ C$ )     | 21         | A             |
| $I_{DM}$           | Pulsed Drain Current                              | 70         | A             |
| $P_D$              | Maximum Power Dissipation                         | 75         | W             |
|                    | Derating factor                                   | 0.5        | W/ $^\circ C$ |
| $E_{AS}$           | Single pulse avalanche energy <sup>(Note 5)</sup> | 256        | mJ            |
| $T_J, T_{STG}$     | Operating Junction and Storage Temperature Range  | -55 To 175 | $^\circ C$    |

## Thermal Characteristic

|                 |  |     |               |
|-----------------|--|-----|---------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case <sup>(Note 2)</sup> | 2.0 | $^{\circ}C/W$ |
|-----------------|--|-----|---------------|

## Electrical Characteristics ( $T_C=25^{\circ}C$ unless otherwise noted)

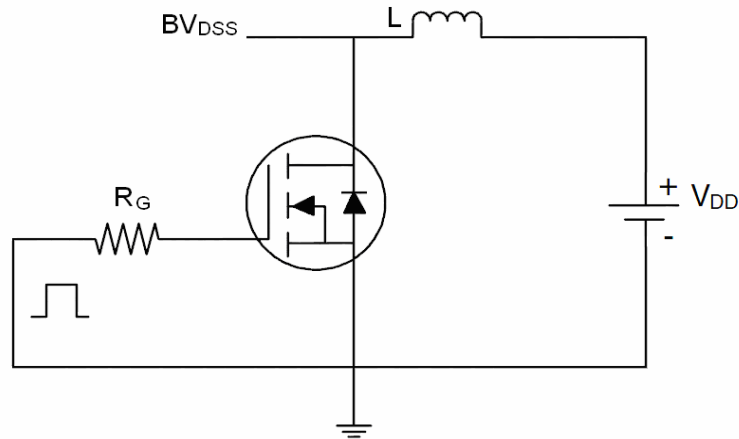
| Symbol   | Parameter                                 | Condition  | Min | Typ  | Max       | Unit       |
|--|---|--|-----|------|-----------|------------|
| <b>Off Characteristics</b>                           |   |  |     |      |           |            |
| $BV_{DSS}$   | Drain-Source Breakdown Voltage            | $V_{GS}=0V, I_D=250\mu A$  | 100 | 110  | -         | V          |
| $I_{DSS}$  | Zero Gate Voltage Drain Current           | $V_{DS}=100V, V_{GS}=0V$   | -   | -    | 1         | $\mu A$    |
| $I_{GSS}$  | Gate-Body Leakage Current                 | $V_{GS}=\pm 20V, V_{DS}=0V$  | -   | -    | $\pm 100$ | nA         |
| <b>On Characteristics</b> <sup>(Note 3)</sup>        |   |  |     |      |           |            |
| $V_{GS(th)}$   | Gate Threshold Voltage                    | $V_{DS}=V_{GS}, I_D=250\mu A$  | 2   | 3    | 4         | V          |
| $R_{DS(ON)}$   | Drain-Source On-State Resistance          | $V_{GS}=10V, I_D=15A$  | -   | 24   | 28        | m $\Omega$ |
| $g_{FS}$   | Forward Transconductance                  | $V_{DS}=5V, I_D=10A$   | -   | 15   | -         | S          |
| <b>Dynamic Characteristics</b> <sup>(Note 4)</sup>   |   |  |     |      |           |            |
| $C_{iss}$  | Input Capacitance                         | $V_{DS}=25V, V_{GS}=0V,$<br>$F=1.0MHz$                                     | -   | 2000 | -         | PF         |
| $C_{oss}$  | Output Capacitance                        |  | -   | 300  | -         | PF         |
| $C_{rSS}$  | Reverse Transfer Capacitance              |  | -   | 250  | -         | PF         |
| <b>Switching Characteristics</b> <sup>(Note 4)</sup> |   |  |     |      |           |            |
| $t_{d(on)}$  | Turn-on Delay Time                        | $V_{DD}=50V, R_L=5\Omega$<br>$V_{GS}=10V, R_{GEN}=3\Omega$                 | -   | 7    | -         | nS         |
| $t_r$  | Turn-on Rise Time                         |  | -   | 7    | -         | nS         |
| $t_{d(off)}$   | Turn-Off Delay Time                       |  | -   | 29   | -         | nS         |
| $t_f$  | Turn-Off Fall Time                        |  | -   | 7    | -         | nS         |
| $Q_g$  | Total Gate Charge                         | $V_{DS}=50V, I_D=18A,$<br>$V_{GS}=10V$                                     | -   | 39   | -         | nC         |
| $Q_{gs}$   | Gate-Source Charge                        |  | -   | 8    | -         | nC         |
| $Q_{gd}$   | Gate-Drain Charge                         |  | -   | 12   | -         | nC         |
| <b>Drain-Source Diode Characteristics</b>            |   |  |     |      |           |            |
| $V_{SD}$   | Diode Forward Voltage <sup>(Note 3)</sup> | $V_{GS}=0V, I_S=20A$   | -   | -    | 1.2       | V          |
| $I_S$  | Diode Forward Current <sup>(Note 2)</sup> | -  | -   | -    | 30        | A          |
| $t_{rr}$   | Reverse Recovery Time                     | $T_J = 25^{\circ}C, I_F = 18A$<br>$di/dt = 100A/\mu s$ <sup>(Note 3)</sup> | -   | 32   | -         | nS         |
| $Q_{rr}$   | Reverse Recovery Charge                   |  | -   | 53   | -         | nC         |
| $t_{on}$   | Forward Turn-On Time                      | Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)       |     |      |           |            |

### Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board,  $t \leq 10$  sec.
3. Pulse Test: Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$ .
4. Guaranteed by design, not subject to production
5. EAS Condition :  $T_J=25^{\circ}C, V_{DD}=50V, V_G=10V, L=0.5mH, R_g=25\Omega, I_{AS}=32A$

**Test Circuit**

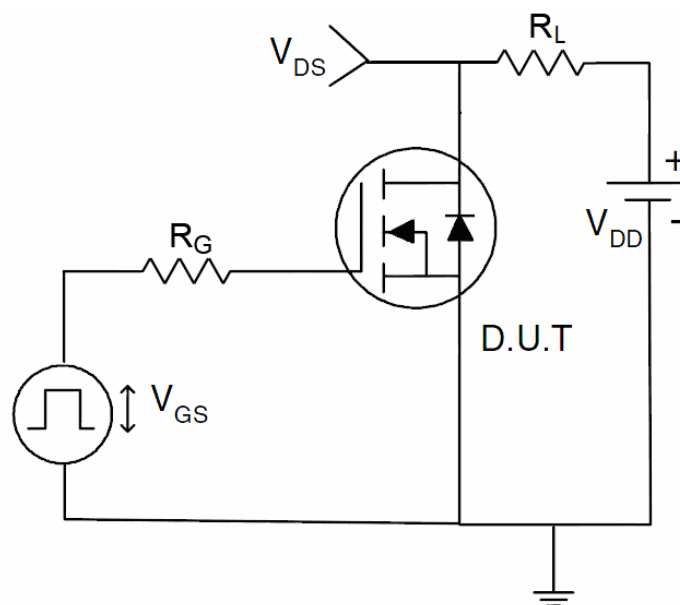
**1) E<sub>AS</sub> Test Circuit**



**2) Gate Charge Test Circuit**



**3) Switch Time Test Circuit**



Typical Electrical and Thermal Characteristics (Curves)

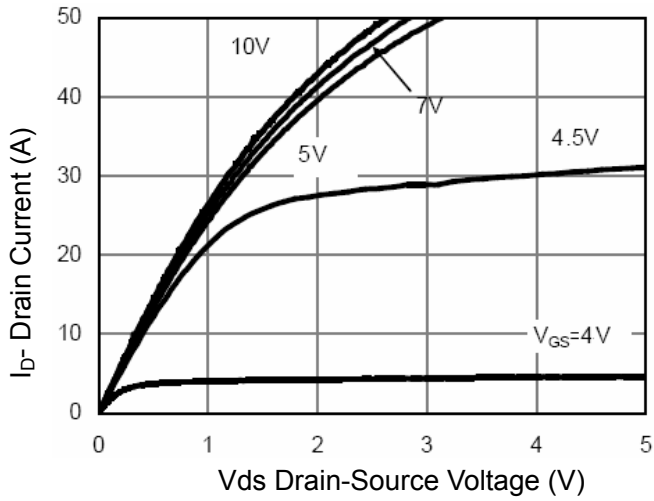


Figure 1 Output Characteristics

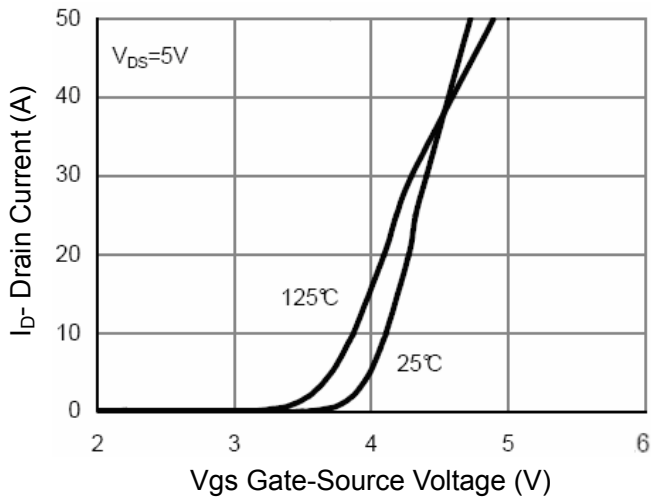


Figure 2 Transfer Characteristics

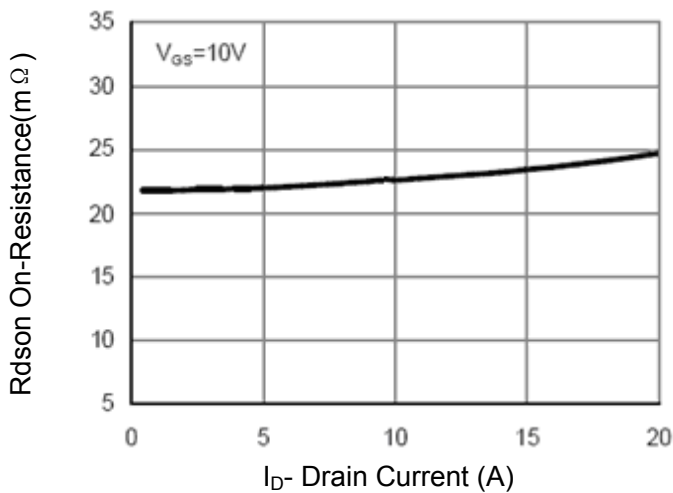


Figure 3 Rdson- Drain Current

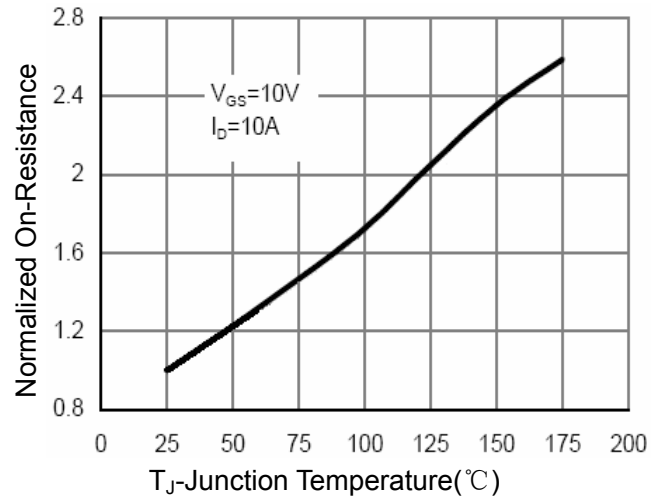


Figure 4 Rdson-Junction Temperature

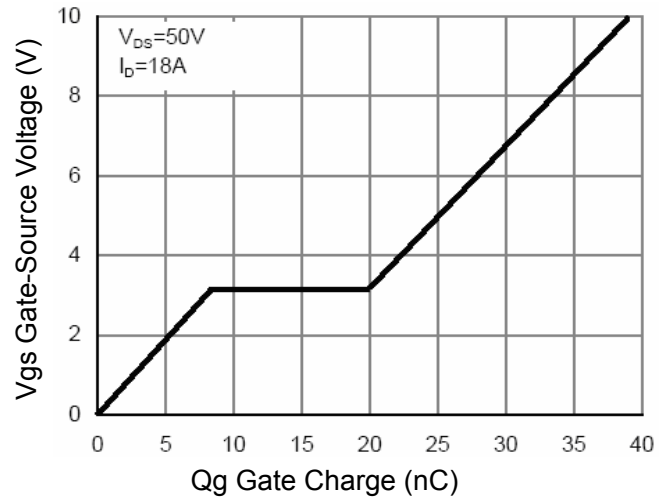


Figure 5 Gate Charge

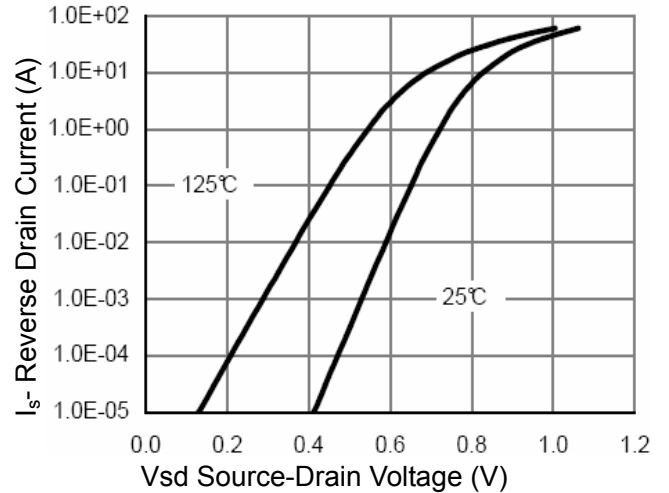


Figure 6 Source- Drain Diode Forward

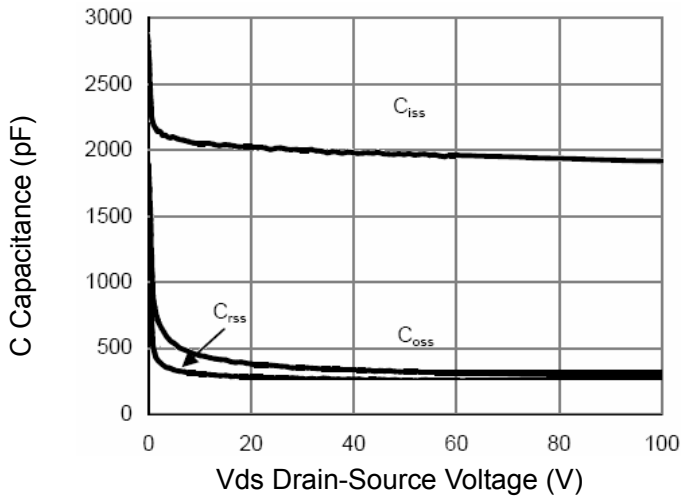


Figure 7 Capacitance vs Vds

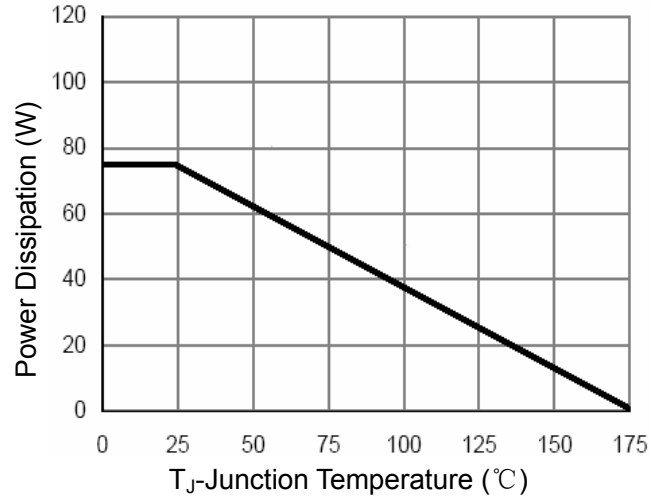


Figure 9 Power De-rating

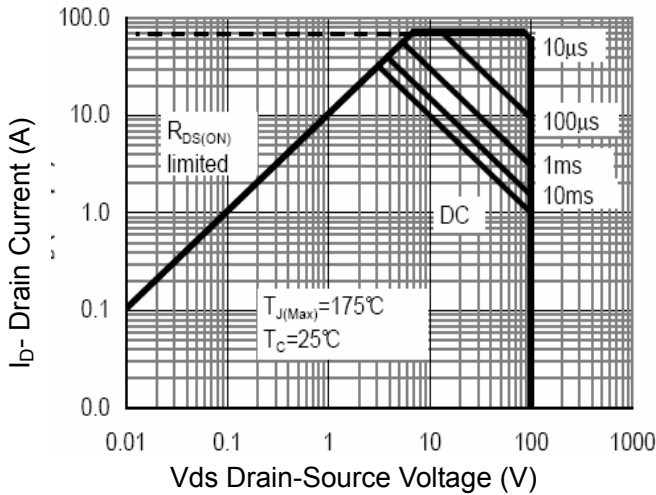


Figure 8 Safe Operation Area

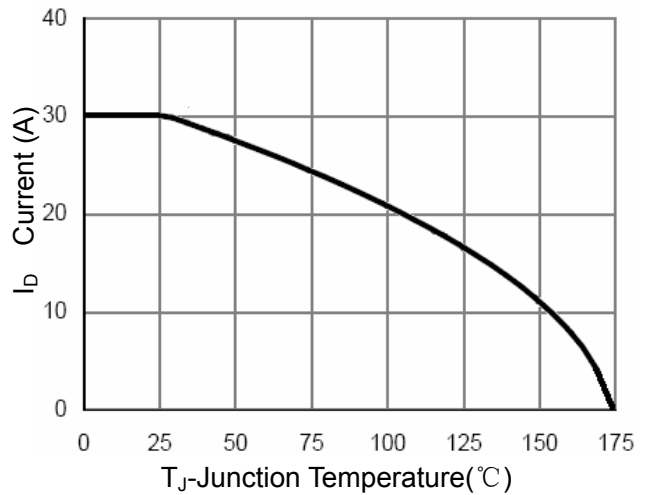


Figure 10 ID Current- Junction Temperature

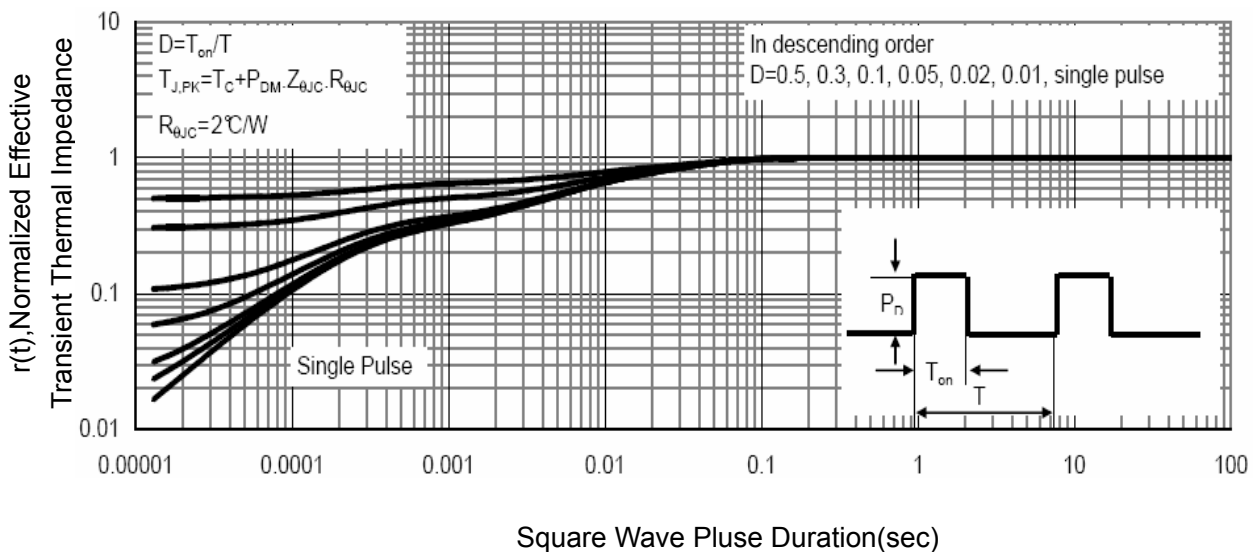
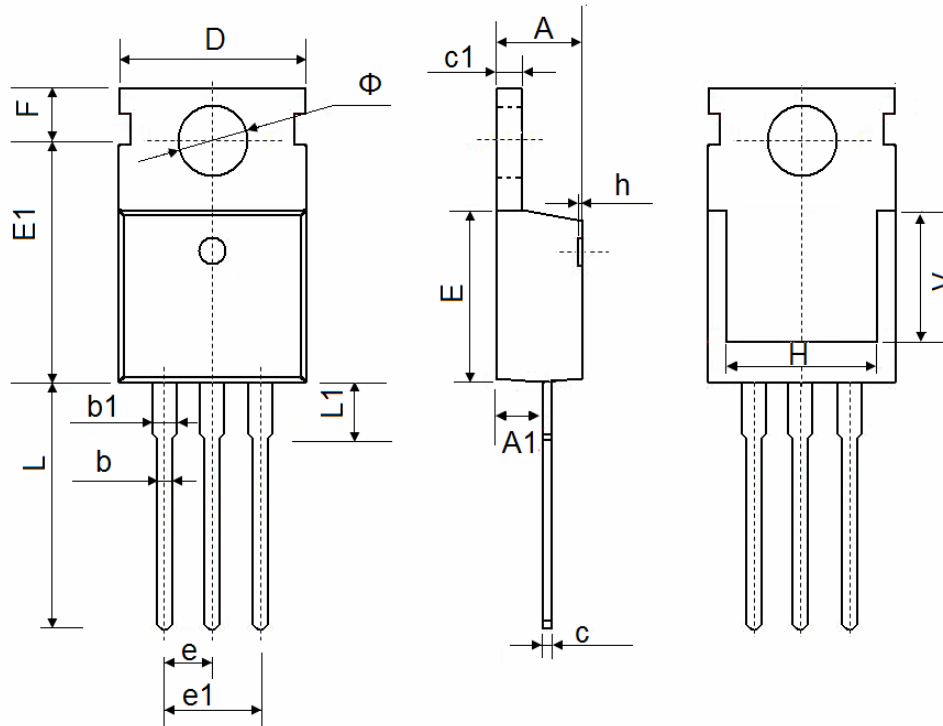


Figure 11 Normalized Maximum Transient Thermal Impedance

**TO-220-3L Package Information**


| Symbol | Dimensions In Millimeters |        | Dimensions In Inches |       |
|--------|---------------------------|--------|----------------------|-------|
|        | Min.                      | Max.   | Min.                 | Max.  |
| A      | 4.400                     | 4.600  | 0.173                | 0.181 |
| A1     | 2.250                     | 2.550  | 0.089                | 0.100 |
| b      | 0.710                     | 0.910  | 0.028                | 0.036 |
| b1     | 1.170                     | 1.370  | 0.046                | 0.054 |
| c      | 0.330                     | 0.650  | 0.013                | 0.026 |
| c1     | 1.200                     | 1.400  | 0.047                | 0.055 |
| D      | 9.910                     | 10.250 | 0.390                | 0.404 |
| E      | 8.9500                    | 9.750  | 0.352                | 0.384 |
| E1     | 12.650                    | 12.950 | 0.498                | 0.510 |
| e      | 2.540 TYP.                |        | 0.100 TYP.           |       |
| e1     | 4.980                     | 5.180  | 0.196                | 0.204 |
| F      | 2.650                     | 2.950  | 0.104                | 0.116 |
| H      | 7.900                     | 8.100  | 0.311                | 0.319 |
| h      | 0.000                     | 0.300  | 0.000                | 0.012 |
| L      | 12.900                    | 13.400 | 0.508                | 0.528 |
| L1     | 2.850                     | 3.250  | 0.112                | 0.128 |
| V      | 7.500 REF.                |        | 0.295 REF.           |       |
| Φ      | 3.400                     | 3.800  | 0.134                | 0.150 |

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